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December 2013

74LCX126 Low Voltage Quad Buffer with 5V Tolerant Inputs and Outputs

Features

- 5V tolerant inputs and outputs
- 2.3V–3.6V V_{CC} specifications provided
- 5.5ns t_{PD} max. ($V_{CC} = 3.3V$), $10\mu A I_{CC}$ max.
- Power down high impedance inputs and outputs
- Supports live insertion/withdrawal⁽¹⁾
- ± 24 mA output drive ($V_{CC} = 3.0$ V)
- Implements proprietary noise/EMI reduction circuitry
- Latch-up performance exceeds JEDEC 78 conditions
- ESD performance:
 - Human body model > 2000V
 - Machine model > 100V
- Leadless DQFN package

Note:

 To ensure the high-impedance state during power up or down, OE should be tied to V_{CC} through a pull-up resistor: the minimum value of the resistor is determined by the current-sourcing capability of the driver.

General Description

The LCX126 contains four independent non-inverting buffers with 3-STATE outputs. Each output is disabled when the associated output-enable (OE) input is LOW. The inputs tolerate voltages up to 7V allowing the interface of 5V systems to 3V systems.

The 74LCX126 is fabricated with an advanced CMOS technology to achieve high speed operation while maintaining CMOS low power dissipation.

Ordering Information

| Order Number | Package Number | Package Description |
|----------------------------|-------------------|---|
| 74LCX126M | M14A | 14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow |
| 74LCX126SJ | M14D | 14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide |
| 74LCX126BQX ⁽²⁾ | MLP14A | 14-Terminal Depopulated Quad Very-Thin Flat Pack No Leads (DQFN), JEDEC MO-241, 2.5 x 3.0mm |
| 74LCX126MTC | MTC14 | 14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide |

Note:

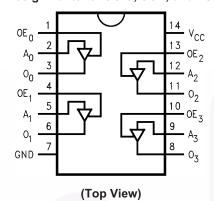
2. DQFN package available in Tape and Reel only.

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering number.

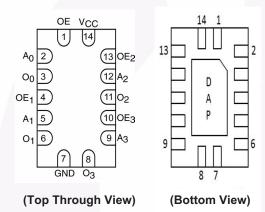
All packages are lead free per JEDEC: J-STD-020B standard.

Connection Diagrams

Pin Assignments for SOIC, SOP, and TSSOP



Pad Assignments for DQFN

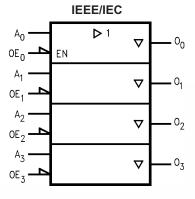


Pin Description

| Pin Names | Description | | |
|-----------------|----------------------|--|--|
| A _n | Inputs | | |
| OE _n | Output Enable Inputs | | |
| O _n | Outputs | | |
| DAP | No Connect | | |

Note: DAP (Die Attach Pad)

Logic Symbol



Truth Table

| Inp | Output | |
|-----|--------|----|
| OEn | An | On |
| Н | L | L |
| Н | Н | Н |
| L | X | Z |

H = HIGH Voltage Level

L = LOW Voltage Level

Z = High Impedance

X = Immaterial

Absolute Maximum Ratings

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

| Symbol | Parameter | Rating |
|------------------|--|---------------------------------|
| V _{CC} | Supply Voltage | -0.5V to +7.0V |
| V _I | DC Input Voltage | -0.5V to +7.0V |
| Vo | DC Output Voltage, | |
| | Output in 3-STATE | -0.5V to +7.0V |
| | Output in HIGH or LOW State ⁽³⁾ | -0.5V to V _{CC} + 0.5V |
| I _{IK} | DC Input Diode Current, V _I < GND | -50mA |
| I _{OK} | DC Output Diode Current | |
| | $V_O < GND$ | _50mA |
| | V _O > V _{CC} | +50mA |
| Io | DC Output Source/Sink Current | ±50mA |
| I _{CC} | DC Supply Current per Supply Pin | ±100mA |
| I _{GND} | DC Ground Current per Ground Pin | ±100mA |
| T _{STG} | Storage Temperature | −65°C to +150°C |

Note:

3. IO Absolute Maximum Rating must be observed.

Recommended Operating Conditions⁽⁴⁾

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. Fairchild does not recommend exceeding them or designing to absolute maximum ratings.

| Symbol | Parameter | Min. | Max. | Units |
|-----------------------------------|--|------|-----------------|------------|
| V _{CC} | Supply Voltage | | | |
| | Operating | 2.0 | 3.6 | V |
| | Data Retention | 1.5 | 3.6 | |
| V _I | Input Voltage | 0 | 5.5 | V |
| Vo | Output Voltage | | | |
| | HIGH or LOW State | 0 | V _{CC} | V |
| | 3-STATE | 0 | 5.5 | |
| I _{OH} / I _{OL} | Output Current | | | |
| | $V_{CC} = 3.0V - 3.6V$ | | ±24 | mA |
| | V _{CC} = 2.7V–3.0V | | ±12 | $P \cap P$ |
| | V _{CC} = 2.3V–2.7V | | ±8 | |
| T _A | Free-Air Operating Temperature | -40 | 85 | °C |
| Δt / ΔV | Input Edge Rate, V _{IN} = 0.8V–2.0V, V _{CC} = 3.0V | 0 | 10 | ns/V |

Note:

4. Unused inputs must be held HIGH or LOW. They may not float.

DC Electrical Characteristics

| | | | | $T_A = -40$ °C | to +85°C | |
|------------------|---------------------------------------|---------------------|--|-----------------------|----------|-------|
| Symbol | Parameter | V _{CC} (V) | Conditions | Min. | Max. | Units |
| V _{IH} | HIGH Level Input Voltage | 2.3–2.7 | | 1.7 | | V |
| | | 2.7–3.6 | | 2.0 | | |
| V _{IL} | LOW Level Input Voltage | 2.3–2.7 | | | 0.7 | V |
| | | 2.7–3.6 | | | 0.8 | |
| V _{OH} | HIGH Level Output Voltage | 2.3–3.6 | $I_{OH} = -100 \mu A$ | V _{CC} - 0.2 | | V |
| | | 2.3 | $I_{OH} = -8mA$ | 1.8 | | |
| | | 2.7 | I _{OH} = -12mA | 2.2 | | |
| | | 3.0 | $I_{OH} = -18mA$ | 2.4 | | |
| | | | $I_{OH} = -24mA$ | 2.2 | | |
| V _{OL} | LOW Level Output Voltage | 2.3–3.6 | $I_{OL} = 100 \mu A$ | | 0.2 | V |
| | | 2.3 | $I_{OL} = 8mA$ | | 0.6 | |
| | | 2.7 | I _{OL} = 12mA | | 0.4 | |
| | | 3.0 | I _{OL} = 16mA | | 0.4 | |
| | | | I _{OL} = 24mA | | 0.55 | |
| I _I | Input Leakage Current | 2.3–3.6 | $0 \le V_I \le 5.5V$ | | ±5.0 | μA |
| I _{OZ} | 3-STATE Output Leakage | 2.3–3.6 | $0 \le V_O \le 5.5V$, $V_I = V_{IH}$ or V_{IL} | | ±5.0 | μΑ |
| I _{OFF} | Power-Off Leakage Current | 0 | V_I or $V_O = 5.5V$ | | 10 | μΑ |
| I _{CC} | Quiescent Supply Current | 2.3–3.6 | $V_I = V_{CC}$ or GND | | 10 | μΑ |
| | | | $3.6V \le V_I, V_O \le 5.5V^{(5)}$ | | ±10 | |
| ΔI_{CC} | Increase in I _{CC} per Input | 2.3–3.6 | $V_{IH} = V_{CC} - 0.6V$ | | 500 | μA |

Note:

5. Outputs disabled or 3-STATE only.

AC Electrical Characteristics

| | | $T_A = -40$ °C to +85°C, $R_L = 500\Omega$ | | | | | | |
|-------------------------------------|--------------------------------------|--|---------------------|-------------------|------|---|------|-------|
| | | | 3V ± 0.3V, 50 pF | V _{CC} = | | V _{CC} = 2.5 C _L = 3 | | |
| Symbol | Parameter | Min. | Max. | Min. | Max. | Min. | Max. | Units |
| t _{PHL} , t _{PLH} | Propagation Delay | 1.5 | 5.5 | 1.5 | 6.0 | 1.5 | 6.6 | ns |
| t _{PZL} , t _{PZH} | Output Enable Time | 1.5 | 6.0 | 1.5 | 7.0 | 1.5 | 7.8 | ns |
| t _{PLZ} , t _{PHZ} | Output Disable Time | 1.5 | 5.5 | 1.5 | 6.5 | 1.5 | 6.6 | ns |
| toshl, toshh | Output to Output Skew ⁽⁶⁾ | | 1.0 | | | | | ns |

Note:

6. Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH-to-LOW (t_{OSHL}) or LOW-to-HIGH (t_{OSLH}).

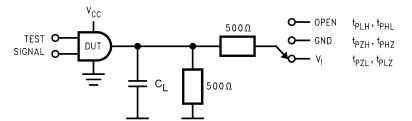
Dynamic Switching Characteristics

| | | | | $T_A = 25^{\circ}C$ | |
|------------------|---|---------------------|---|---------------------|------|
| Symbol | Parameter | V _{CC} (V) | Conditions | Typical | Unit |
| V _{OLP} | Quiet Output Dynamic Peak V _{OL} | 3.3 | $C_L = 50pF, V_{IH} = 3.3V, V_{IL} = 0V$ | 0.8 | V |
| | | 2.5 | $C_L = 30 pF, V_{IH} = 2.5 V, V_{IL} = 0 V$ | 0.6 | |
| V _{OLV} | Quiet Output Dynamic Valley V _{OL} | 3.3 | $C_L = 50 pF, V_{IH} = 3.3 V, V_{IL} = 0 V$ | -0.8 | V |
| | | 2.5 | $C_L = 30pF, V_{IH} = 2.5V, V_{IL} = 0V$ | -0.6 | |

Capacitance

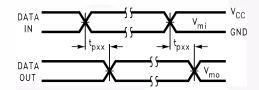
| Symbol | Parameter | Conditions | Typical | Units |
|------------------|-------------------------------|--|---------|-------|
| C _{IN} | Input Capacitance | $V_{CC} = Open, V_I = 0V \text{ or } V_{CC}$ | 7 | pF |
| C _{OUT} | Output Capacitance | $V_{CC} = 3.3V$, $V_I = 0V$ or V_{CC} | 8 | pF |
| C _{PD} | Power Dissipation Capacitance | $V_{CC} = 3.3V$, $V_I = 0V$ or V_{CC} , $f = 10MHz$ | 25 | pF |

AC Loading and Waveforms (Generic for LCX Family)

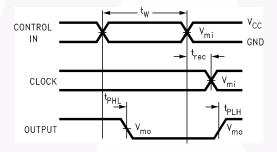


| Test | Switch |
|-------------------------------------|---|
| t _{PLH} , t _{PHL} | Open |
| t_{PZL}, t_{PLZ} | 6V at $V_{CC} = 3.3 \pm 0.3V$ $V_{CC} \times 2$ at $V_{CC} = 2.5 \pm 0.2V$ |
| t _{PZH} , t _{PHZ} | GND |

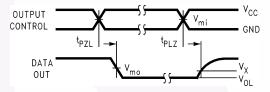
Figure 1. AC Test Circuit (C_L includes probe and jig capacitance)



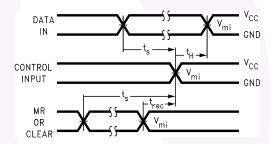
Waveform for Inverting and Non-Inverting Functions



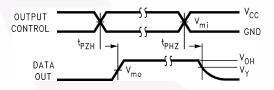
Propagation Delay. Pulse Width and t_{rec} Waveforms



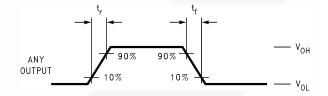
3-STATE Output High Enable and Disable Times for Logic



Setup Time, Hold Time and Recovery Time for Logic



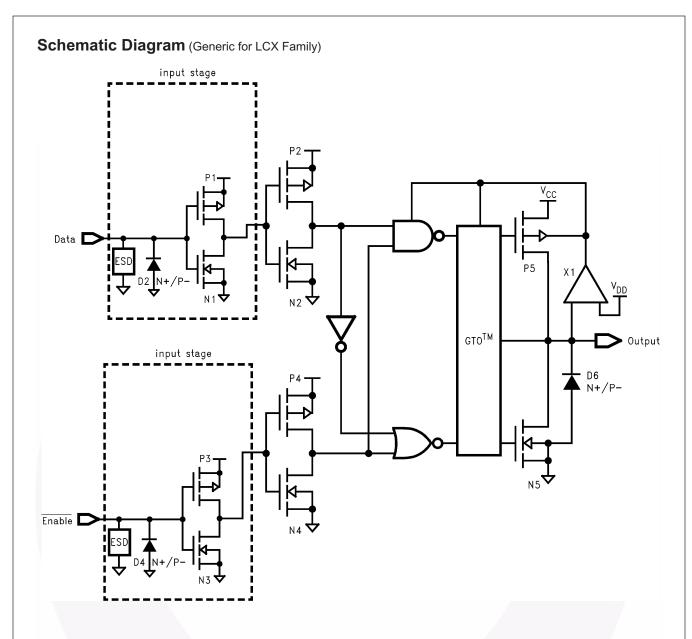
3-STATE Output Low Enable and Disable Times for Logic



t_{rise} and t_{fall}

| | | V _{cc} | | | |
|-----------------|------------------------|------------------------|-------------------------|--|--|
| Symbol | 3.3V ± 0.3V | 2.7V | 2.5V ± 0.2V | | |
| V _{mi} | 1.5V | 1.5V | V _{CC} /2 | | |
| V_{mo} | 1.5V | 1.5V | V _{CC} /2 | | |
| V _x | V _{OL} + 0.3V | V _{OL} + 0.3V | V _{OL} + 0.15V | | |
| V _y | V _{OH} – 0.3V | V _{OH} – 0.3V | V _{OH} – 0.15V | | |

Figure 2. Waveforms (Input Characteristics; f = 1MHz, $t_r = t_f = 3ns$)

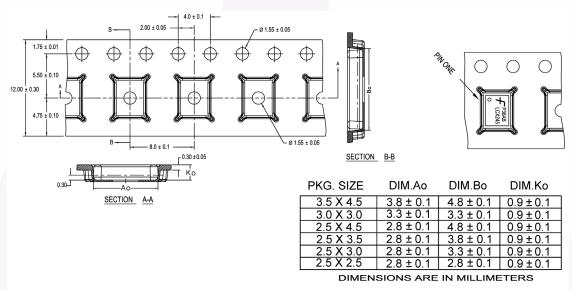


Tape and Reel Specification

Tape Format for DQFN

| Package Designator | Tape Section | Number of Cavities | Cavity Status | Cover Tape Status |
|--------------------|--------------------|--------------------|---------------|-------------------|
| BQX | Leader (Start End) | 125 (Typ.) | Empty | Sealed |
| | Carrier | 3000 | Filled | Sealed |
| | Trailer (Hub End) | 75 (Typ.) | Empty | Sealed |

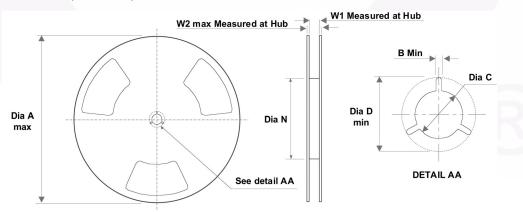
Tape Dimensions inches (millimeters)



NOTES: unless otherwise specified

- 1. Cummulative pitch for feeding holes and cavities (chip pockets) not to exceed 0.008[0.20] over 10 pitch span.
- 2. Smallest allowable bending radius.
- 3. Thru hole inside cavity is centered within cavity.
- 4. Tolerance is $\pm 0.002[0.05]$ for these dimensions on all 12mm tapes.
- 5. Ao and Bo measured on a plane 0.120[0.30] above the bottom of the pocket.
- 6. Ko measured from a plane on the inside bottom of the pocket to the top surface of the carrier.
- 7. Pocket position relative to sprocket hole measured as true position of pocket. Not pocket hole.
- 8. Controlling dimension is millimeter. Diemension in inches rounded

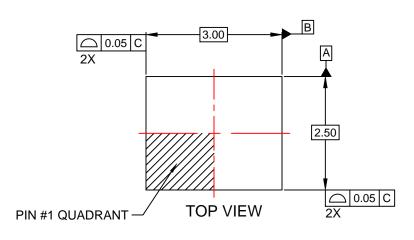
Reel Dimensions inches (millimeters)

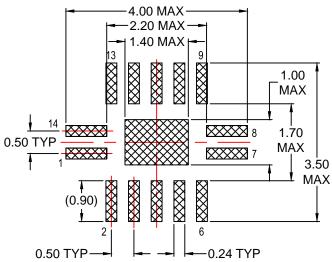


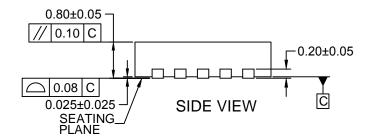
| Tape Size | Α | В | С | D | N | W1 | W2 |
|-----------|--------------|--------------|---------------|---------------|---------------|--------------|--------------|
| 12mm | 13.0 (330.0) | 0.059 (1.50) | 0.512 (13.00) | 0.795 (20.20) | 2.165 (55.00) | 0.488 (12.4) | 0.724 (18.4) |



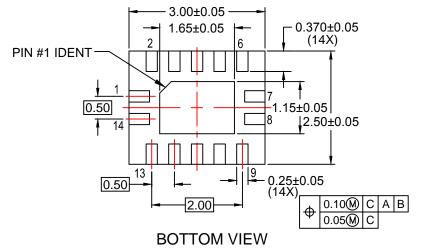








RECOMMENDED LAND PATTERN



NOTES:

- A. CONFORMS TO JEDEC REGISTRATION MO-241, VARIATION AA
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
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74AUP1G34FW5-7 74AUP1G07FW5-7 74LVC2G126RA3-7 NLX2G17CMUTCG 74LVCE1G125FZ4-7 Le87501NQC 74AUP1G126FW5-7 TC74HC4050AP(F) 74LVCE1G07FZ4-7 NLX3G16DMUTCG NLX2G06AMUTCG NLVVHC1G50DFT2G NLU2G17AMUTCG
LE87100NQC LE87290YQC LE87290YQCT LE87511NQC LE87511NQCT LE87557NQC LE87557NQCT LE87614MQC
LE87614MQCT 74AUP1G125FW5-7 NLU2G16CMUTCG MC74LCX244MN2TWG NLV74VHC125DTR2G NL17SG126DFT2G